

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination SEKI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
X	A	US-5897328	04-1999	Yamauchi et al.	438	
X	B	US-5970318	10-1999	Choi et al.	438	
	C	US-				
	D	US-				
	E	US-				
	F	US-				
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	I	US-				
	J	US-				
	K	US-				
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	M	US-				

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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